



FORM PTO-1449/A and B (Modified)  INFORMATION DISCLOSURE STATEMENT BY APPLICANT	APPLICATION NO.: 09/361,700		ATTY. DOCKET NO.: S01022.80201.US
	FILING DATE: July 27, 1999		CONFIRMATION NO.: 5850
	APPLICANT: Pierrick Descure		
	GROUP ART UNIT: 2811		EXAMINER: Gene M. Munson.
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EXAMINER <b>G. MUNSON</b>	DATE CONSIDERED <b>5 AUGUST 2005</b>
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#EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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